

Issue Classification	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10005193	CHEN ET AL.
	Examiner	Art Unit
	Ehichioya, Fred I	2162

Enchichoya, Fred J. <i>Fred Enchichoya</i> (Assistant Examiner)	10/18/2007 (Date)	<i>John E. Breene</i>	Total Claims Allowed: 20	
<i>K. Davis</i> (Legal Instruments Examiner)	11/2/07 (Date)	JOHN BREENE SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2100 (Primary Examiner) <i>11/30/05</i> (Date)	O.G. Print Claim(s) 1	O.G. Print Figure 4